


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527140	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASE ET AL.
	<b>Examiner</b>  Cwern, Jonathan G	<b>Art Unit</b>  3737

SEARCHED			
Class	Subclass	Date	Examiner
600	454, 465, 468, 504	6/2/08	JC

SEARCH NOTES		
Search Notes	Date	Examiner
See attached EAST search	10/6/07	JC
Updated EAST search	6/2/08	JC
Updated EAST search	12/12/08	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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